MOSFET – Power

-60 V, -20 A, 52 m Ω

Features

- Low R_{DS(on)}
- Fast Switching
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Load Switches
- DC Motor Control
- DC-DC Conversion

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

| Paran | Symbol | Value | Unit | | |
|---|--------------------------------------|------------------------|-----------------|------|----|
| Drain-to-Source Voltage | V_{DSS} | -60 | ٧ | | |
| Gate-to-Source Voltage | | | V_{GS} | ±20 | ٧ |
| Continuous Drain | | T _A = 25°C | I _D | -5.7 | Α |
| Current R _{θJA} (Note 1) | | T _A = 100°C | | -4.0 | |
| Power Dissipation R _{θJA} | | T _A = 25°C | P_{D} | 3.2 | W |
| (Note 1) | Steady | T _A = 100°C | | 1.6 | |
| Continuous Drain | State | T _C = 25°C | I _D | -20 | Α |
| Current R _{θJC} (Note 1) | | T _C = 100°C | | -14 | |
| Power Dissipation | | T _C = 25°C | P_{D} | 40 | W |
| R _{θJC} (Note 1) | | $T_C = 100^{\circ}C$ | | 20 | |
| Pulsed Drain Current t _p = 10 μs | | | I _{DM} | -76 | Α |
| Operating Junction and S | T _J , T _{stg} | -55 to +175 | °C | | |
| Source Current (Body Die | I _S | -20 | Α | | |
| Single Pulse Drain-to-Source Ava- L = 0.1 mH | | | E _{AS} | 45 | mJ |
| lanche Energy | | | I _{AS} | 30 | Α |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | TL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|--|---------------|-------|------|
| Junction-to-Case - Steady State (Note 1) | $R_{	hetaJC}$ | 3.8 | °C/W |
| Junction-to-Ambient - Steady State (Note 1) | $R_{	hetaJA}$ | 47 | |

 Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces.

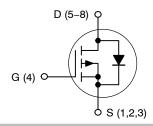


ON Semiconductor®

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| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| -60 V | 52 mΩ @ –10 V | -20 A |
| | 72 mΩ @ -4.5 V | -20 A |

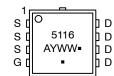
P-Channel MOSFET





CASE 511AB

MARKING DIAGRAM



5116 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week • = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|----------------|--------------------|-----------------------|
| NTTFS5116PLTAG | WDFN8 (Pb-Free) | 1500/Tape & Reel |
| NTTFS5116PLTWG | WDFN8 (Pb-Free) | 5000/Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|--------------------------------------|---|--|-----|-------|------|------------|
| OFF CHARACTERISTICS | | | | | | | - 1 |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | | -60 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | | | | 69.7 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | T _J = 25°C | | | -1.0 | μΑ |
| | | $V_{DS} = -60 \text{ V}$ | T _J = 125°C | | | -100 | 7 |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} = | = ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 2) | | | | | | • | • |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}$, $I_D = -$ | -250 μΑ | -1 | | -3 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -6.2 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = −10 V | I _D = -6 A | | 37 | 52 | mΩ |
| | | V _{GS} = -4.5 V | I _D = -4.4 A | | 51 | 72 | 1 |
| Forward Transconductance | 9FS | $V_{DS} = -15 \text{ V}, I_D$ | = -6 A | | 11 | | S |
| CHARGES, CAPACITANCES AND GA | ATE RESISTAN | ICE | <u>. </u> | | | 1 | |
| Input Capacitance | C _{iss} | | | | 1258 | | pF |
| Output Capacitance | C _{oss} | V _{GS} = 0 V, f = 1.0 MHz | , V _{DS} = -30 V | | 127 | | 1 |
| Reverse Transfer Capacitance | C _{rss} | , , , , , | | | 84 | | |
| Total Gate Charge | Q _{G(TOT)} | $V_{GS} = -10 \text{ V}, V_{DS} = -4$ | 8 V, I _D = -5 A | | 25 | | nC |
| | | $V_{GS} = -4.5 \text{ V}, V_{DS} = -4.5 \text{ V}$ | 18 V, I _D = -5 A | | 14 | | |
| Threshold Gate Charge | Q _{G(TH)} | | | | 1 | | nC |
| Gate-to-Source Charge | Q _{GS} | | | | 4 | | 1 |
| Gate-to-Drain Charge | Q_{GD} | $V_{GS} = -4.5 \text{ V}, V_{DS} = -4.5 \text{ V}$ | l8 V, I _D = −5 A | | 7 | | |
| Plateau Voltage | V_{GP} | | | | 3.1 | | V |
| Gate Resistance | R_{G} | | | | 5.3 | | Ω |
| SWITCHING CHARACTERISTICS (No | ote 3) | | • | | | | |
| Turn-On Delay Time | t _{d(on)} | | | | 15 | | ns |
| Rise Time | t _r | V_{GS} = -4.5 V, V_{DS} = -48 V, I_{D} = -5 A, R_{G} = 6 Ω | | | 58 | | 1 |
| Turn-Off Delay Time | t _{d(off)} | | | | 30 | | 1 |
| Fall Time | t _f | | | | 37 | | 1 |
| DRAIN-SOURCE DIODE CHARACTE | RISTICS | | L | | • | | • |
| Forward Diode Voltage | V _{SD} | $V_{GS} = 0 V$, $I_S = -5 A$ | T _J = 25°C | | -0.79 | -1.2 | V |
| | | | T _J = 125°C | | -0.64 | | |
| Reverse Recovery Time | t _{RR} | V_{GS} = 0 V, d_{IS}/d_t = -100 A/ μ s, I_S = -5 A | | | 20 | | ns |
| Charge Time | t _a | | | | 15 | | 1 |
| Discharge Time | t _b | | | | 5 | | 1 |
| Reverse Recovery Charge | Q _{RR} | | | | 19 | | nC |

^{2.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 3. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

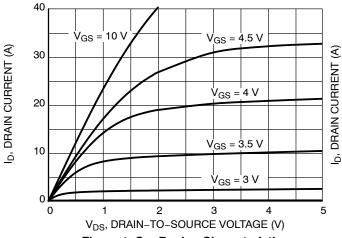


Figure 1. On-Region Characteristics

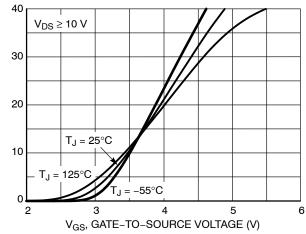


Figure 2. Transfer Characteristics

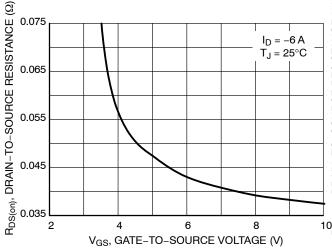


Figure 3. On-Resistance vs. Gate-to-Source Voltage

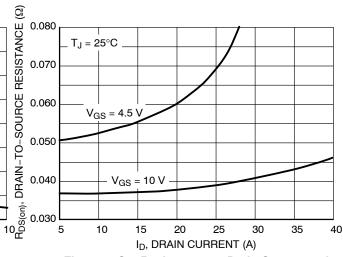


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

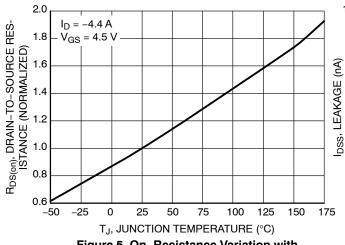


Figure 5. On–Resistance Variation with Temperature

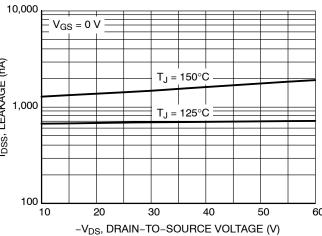


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

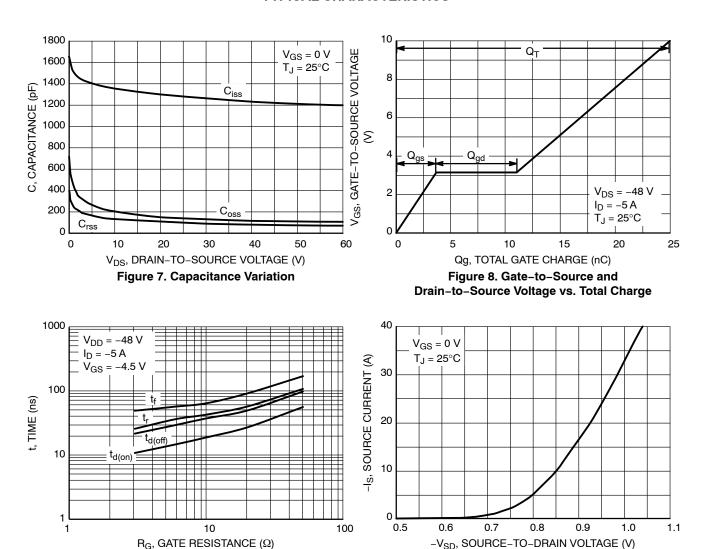


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

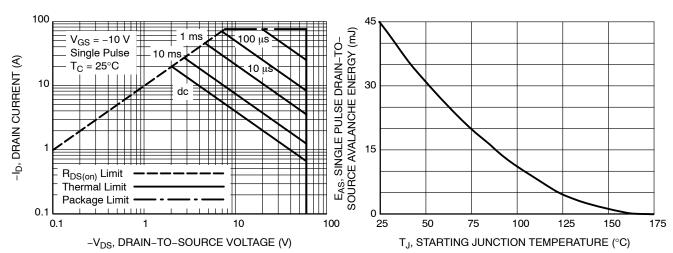


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

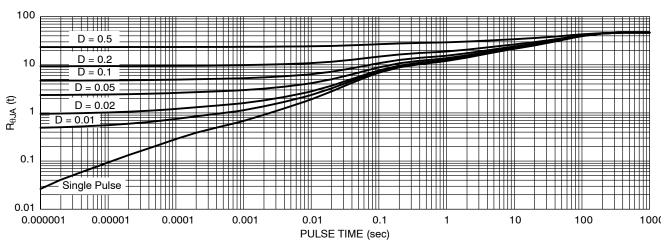
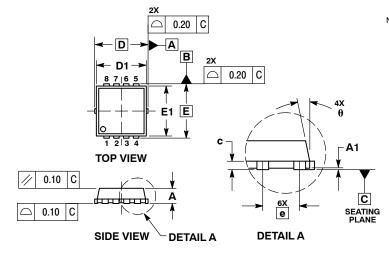


Figure 13. Thermal Response

PACKAGE DIMENSIONS

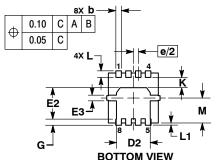
WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

| | MILLIMETERS | | | | INCHES | |
|-----|-------------|----------|------|-----------|----------|-------|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX |
| Α | 0.70 | 0.75 | 0.80 | 0.028 | 0.030 | 0.031 |
| A1 | 0.00 | | 0.05 | 0.000 | | 0.002 |
| b | 0.23 | 0.30 | 0.40 | 0.009 | 0.012 | 0.016 |
| С | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 |
| D | 3.30 BSC | | | 0 | .130 BSC | |
| D1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 |
| D2 | 1.98 | 2.11 | 2.24 | 0.078 | 0.083 | 0.088 |
| E | | 3.30 BSC | ; | 0.130 BSC | | |
| E1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 |
| E2 | 1.47 | 1.60 | 1.73 | 0.058 | 0.063 | 0.068 |
| E3 | 0.23 | 0.30 | 0.40 | 0.009 | 0.012 | 0.016 |
| е | 0.65 BSC | | | 0.026 BSC | | |
| G | 0.30 | 0.41 | 0.51 | 0.012 | 0.016 | 0.020 |
| K | 0.65 | 0.80 | 0.95 | 0.026 | 0.032 | 0.037 |
| L | 0.30 | 0.43 | 0.56 | 0.012 | 0.017 | 0.022 |
| L1 | 0.06 | 0.13 | 0.20 | 0.002 | 0.005 | 800.0 |
| М | 1.40 | 1.50 | 1.60 | 0.055 | 0.059 | 0.063 |
| θ | 0 ° | | 12 ° | 0 ° | | 12 ° |



SOLDERING FOOTPRINT* 4X ⊢0.66 PACKAGE OUTLINE 3.60 2.30 0.57 0.47 2.37 3.46

DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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